

# Thermal Boundary Conductance: A Materials Science Perspective

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#### **Abstract**

The thermal boundary conductance (TBC) of materials pairs in atomically intimate contact is reviewed as a practical guide for materials scientists. First, analytical and computational models of TBC are reviewed. Five measurement methods are then compared in terms of their sensitivity to TBC: the  $3\omega$  method, frequency- and time-domain thermoreflectance, the cut-bar method, and a composite effective thermal conductivity method. The heart of the review surveys 30 years of TBC measurements around room temperature, highlighting the materials science factors experimentally proven to influence TBC. These factors include the bulk dispersion relations, acoustic contrast, and interfacial chemistry and bonding. The measured TBCs are compared across a wide range of materials systems by using the maximum transmission limit, which with an attenuated transmission coefficient proves to be a good guideline for most clean, strongly bonded interfaces. Finally, opportunities for future research are discussed.

# **TBC:** thermal boundary conductance, *h* [W/(m<sup>2</sup>·K)]

MMC: metal-matrix composite

#### 1. INTRODUCTION

#### 1.1. Motivation and Applications

Heat transfer through interfaces is becoming ever more important in modern technology. Indeed, although the relentless miniaturization of microelectronics and other functional devices enables their continued performance increases, it has also created a major problem in the thermal domain: Much effort is now needed to avoid overheating in the active area, which is crucial for semiconductor devices such as microprocessors, diodes, diode lasers, and high-electron-mobility transistors.

Miniaturization is thermally unfavorable for three reasons, as exemplified in microprocessors. (a) As the same functionality is achieved in a smaller device, the heat dissipation per unit volume increases. (b) Functionality often actually increases with each technology generation. (c) The greater density of interfaces impedes the heat flow out of the device, which is further exacerbated by the shift to 3D architectures such as Intel's Tri-gate<sup>®</sup>.

A critical scale for comparing bulk and interfacial thermal resistances is the Kapitza length,  $L_{\rm K}$ , defined as the ratio of the material's thermal conductivity k to thermal boundary conductance (TBC). By using silicon as a representative benchmark for k, this crossover length for TBC dominance ranges widely, from as low as tens of nanometers for a high-quality Pd/Ir interface (1) to as large as tens of micrometers for a highly mismatched Bi/diamond interface (2), values made even larger by any contamination at the interface (3). Because many modern devices rely on feature sizes and film thicknesses smaller than  $L_{\rm K}$ , the interfaces play a crucial role in limiting heat dissipation.

TBC is similarly important for many other modern semiconductor technologies that also contain a high density of nanoscale interfaces by design. Such technologies include optoelectronic devices such as quantum dot lasers (4), heat-assisted magnetic recording heads (5), and vertical cavity surface emitting lasers (6) and resonant diodes (7) based on superlattice Bragg mirrors. For these applications, thermal issues are critical because the maximum light output is limited by overheating of the active region. Similar issues arise in emerging fields such as organic electronics, which rely on metal contacts to cool the thermally insulating polymer device regions (8). TBC also dominates the heat transfer between 1D, 2D, and layered nanomaterials and their substrates (9–11), configurations being proposed for future electronic devices (12, 13). TBC is moreover a limiting parameter in high-electron-mobility transistors, especially those on next-generation diamond substrates (14).

TBC also plays an important yet underappreciated role in macroscopic thermal management materials. Hence, metal-matrix composites (MMCs) based on highly conductive inclusions (15) such as diamonds (16, 17), AlN (18), SiC, and carbon nanotubes (CNTs) (19) perform far below their full potential because their effective thermal conductivity is ultimately limited by the matrix/inclusion TBC (20). The low TBC at internal CNT-CNT junctions, as well as at CNT connections to the host polymer and surrounding boundaries, prevents the use of CNTs in thermal interface materials (21). Similarly, TBC is a crucial parameter in phase change materials for data storage (22) as well as in composites for thermal energy storage (23). TBC due to scattering at grain boundaries can also be a limiting factor for heat conduction in nanograined polycrystalline solids. However, low TBC can be exploited to tailor ultralow thermal conductivities by engineering nanolaminates (24) or nanocomposites (25), with potential applications including thermoelectric energy conversion and thermal barrier coatings.

#### 1.2. Scope and Related Work

Several earlier reviews contain a wealth of information about TBC. The classic article by Swartz & Pohl (26) summarized measurements and physical understanding of TBC at low and ultralow temperatures (0.1–30 K) developed through 1987 and presented the acoustic and diffuse mismatch

models (AMM and DMM, respectively) and the phonon radiation limit (RL), all of which are still in use today. Later, Cahill and coauthors (27, 28) discussed TBC, including measurements, simulation, and selected experimental results, as part of broader reviews on nanoscale thermal transport. Finally, a recent review by Hopkins (29) summarized the effects of various experimental parameters on TBC, mainly that between metals and dielectrics.

The present article emphasizes the materials science of TBC and the phenomena around room temperature. We begin by briefly establishing the fundamental concepts and equations for the TBC between materials in intimate contact. TBC measurement techniques are then assessed in terms of their sensitivity. The article culminates by reviewing the TBC experimental literature from the past 30 years (see **Figures 5–7** below), discussed from a materials science perspective. Throughout, the two essential themes for understanding TBC are the heat carrier irradiance and the interfacial chemistry and bonding. The thermal conductance of grain boundaries is not directly treated here (except briefly in Section 3.3.2), although it can be understood using many of the same principles as the ones discussed below.

#### 2. THEORETICAL FOUNDATION: PHYSICAL ORIGINS OF TBC

To introduce the theoretical concepts used to understand TBC, we begin with a very general Landauer-Büttiker perspective. This approach highlights the two complementary factors determining the TBC in real experimental systems: the flux of energy carriers irradiating the interface and the ease of carrier transmission through the interface. We then discuss the strengths and limitations of the various approximations used to make the Landauer-Büttiker formulation tractable for simple calculations.

#### 2.1. Definition

When a heat flux J passes through a dense solid/solid interface, it causes a proportional temperature difference  $\Delta T$  through it so that  $J = h \Delta T$ . Here h is the TBC between the two solids, expressed in W/(m<sup>2</sup>·K).

## 2.2. Landauer-Büttiker Formulation: TBC Depends on Irradiance and Transmission Coefficient

We present only the highlights of the main theory of TBC. More details are available in References 26 and 30. The equations are discussed in terms of phonons, but the fundamental concepts and results for electrons are identical after replacing Bose-Einstein statistics with Fermi-Dirac statistics. Similarly, we assume that both materials have isotropic dispersion relations, with a suitable generalization to highly anisotropic materials available in Reference 31.

**2.2.1. Main analytical results.** The essential picture is that of carrier bombardment and transmission (**Figure 1***b*,*c*), which is readily analyzed using a Landauer-Büttiker formulation. This approach neglects coupled multicarrier effects and any inelastic scattering such as three-phonon processes at the interface. The interface (x = 0) is continually irradiated from both sides (i = 1, 2) by phonons of various frequencies ( $\omega$ ), polarizations (p), and directions (p,  $\varphi$ ). The total energy flux incident from side p is the irradiance (in W/m²),

$$H_{i} = \sum_{p} \int_{\omega=0}^{\omega_{\max,i}} \int_{\varphi=0}^{2\pi} \int_{\theta=0}^{\pi/2} \eta_{i} f_{i} \sin \theta d\theta d\varphi d\omega.$$
 1.

Here f is the Bose-Einstein factor using temperature  $T_i$ , and the integration is over only the incident hemisphere. We also introduce a modewise intensity  $\eta_i = \frac{1}{4\pi}\hbar\omega v_i \cos\theta D_i$ , where  $\hbar$  is

**AMM:** acoustic mismatch model of TBC

**DMM:** diffuse mismatch model of TBC

RL: radiation limit of TBC

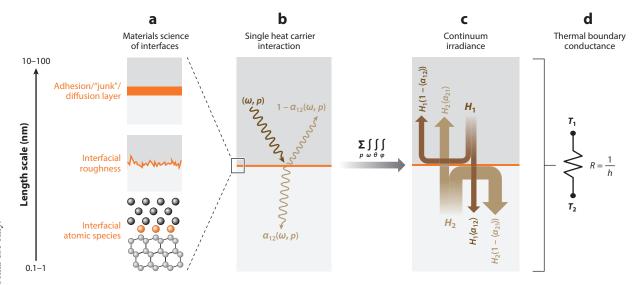


Figure 1

Relationship between microscopic and macroscopic pictures of thermal boundary conductance. (a) The interface (orange) is defined by its micro- and nanostructural features. (b) An individual heat carrier of frequency  $\omega$  and polarization p strikes the interface, with a transmission probability  $\alpha_{12}$ . (c) Integrating over all carriers gives the total irradiance,  $H_1$ , with a weighted average transmission coefficient  $\langle \alpha_{12} \rangle$ . (d) The resulting heat transfer is equivalent to that of a simple thermal resistor.

the reduced Planck's constant,  $v_i(\omega, p)$  is the group velocity, and  $D_i(\omega, p)$  is the density of states (DOS).

Any given carrier (specified by  $\omega$ ,  $\theta$ ,  $\phi$ , p, and i) has a probability  $\alpha_{ij}$  to transmit through the interface and deposit its energy in material j. If this  $\alpha_{ij}$  is inserted into Equation 1 and the two sides are allowed to be at different temperatures, the net heat flux can be written as  $q_{\text{net}} = q_{12} - q_{21}$ , where

$$q_{ij} = \sum_{p} \iiint_{\omega,\theta,\varphi} \eta_i f_i \alpha_{ij} \sin\theta d\theta \varphi d\omega, \qquad 2.$$

with the angular integration again over the incident hemisphere. This microscopic formulation of  $q_{\text{net}}$  is linked to the macroscopic irradiance picture of **Figure 1**b by defining an averaged transmission coefficient

$$\alpha_{ij} = q_{ij}/H_i, 3.$$

leading to

$$q_{\text{net}} = [H_1 \alpha_{12}]_{T_1} - [H_2 \alpha_{21}]_{T_2},$$

$$4.$$

as illustrated in **Figure 1**c. At equilibrium,  $q_{\text{net}} = 0$ , which requires  $[H_1\alpha_{12}]_T = [H_2\alpha_{21}]_T$  (30).

Finally, to obtain the linear response coefficient  $b = \frac{\partial q_{\rm net}}{\partial (\Delta T)}$ , consider a small temperature difference across the interface, and let  $\Delta T \to 0$ . Then

$$b = \frac{\partial}{\partial T} [H_1 \alpha_{12}] = \frac{\partial}{\partial T} [H_2 \alpha_{21}].$$
 5.

The equivalence of the  $H_1$  and  $H_2$  forms of Equation 5 means that TBC can be analyzed from the perspective of whichever material is more convenient. The other material still enters the problem, of course, through the transmission coefficients  $\alpha_{ij}$ .

Often  $\eta_i$  and  $\alpha_{ij}$  are independent of T, in which case

$$b = \sum_{b} \iiint_{\omega,\theta,\varphi} \eta_{i} \frac{\partial f_{i}}{\partial T} \alpha_{ij} \sin\theta \, d\theta \, d\varphi \, d\omega.$$
 6.

This is a good approximation except near phase transition temperatures and in highly anharmonic materials.

Because the irradiation H is likely unfamiliar to many readers (although it is a standard concept in radiation heat transfer), for physical insight it is helpful to consider a Debye model, which has a linear phonon dispersion of sound speed v. In this special case,

$$\frac{\partial H_i}{\partial T} = \frac{1}{4} \sum_{p} C_{i,p} v_{i,p},$$
 7.

where *C* is the heat capacity per unit volume. Thus, we have the critical insight that TBC is closely related to a material's heat capacity and carrier velocities.

#### 2.2.2. The paradox of the imaginary interface: incident versus equilibrium temperatures.

The main results for b in Equations 5 and 6 have a conceptual flaw in the limit of an imaginary interface within a single material, which should give  $b = \infty$ . However, with  $H_1 = H_2$  and  $\alpha = 1$  for all carriers, Equations 5 and 6 clearly give a finite b. This is known as the Kapitza paradox. It can be resolved by redefining the local temperature to account for both incident and outgoing carriers (30). This approach is equivalent to multiplying the b expressions from Equations 5 and 6 by a factor like  $[1 - \frac{1}{2}(\langle \alpha_{12} \rangle + \langle \alpha_{21} \rangle)]^{-1}(31)$ . This temperature artifact correction can safely be ignored for most real interfaces.

#### 2.3. The Three Quantities Controlling TBC

Equations 5 and 6 reveal the three main phenomena controlling TBC and are used throughout this review to interpret existing models and experiments. See also **Figure 1**.

- **2.3.1.** Dispersion relation. TBC scales with H, the irradiance of phonons bombarding the interface. This scaling calls for materials whose dispersion relations give large values of the  $C \cdot v$  product (see Equation 7). At temperatures comparable to or higher than the Debye temperature  $\Theta_D$ , the phonon C approaches the constant Dulong-Petit limit. In this case, TBC tends to be higher in materials with stiffer bonding and lighter atoms because of the large sound velocities of such materials. Conversely, at very low temperatures TBC is maximized in materials with low sound velocities due to the  $v^{-3}$  dependence of the Debye heat capacity.
- **2.3.2. Temperature.** Temperature has a direct impact through  $\frac{\partial f}{\partial T}$  in Equation 6 or C(T) in Equation 7. Thus, in phonon-dominated materials one finds  $b \propto T^3$  for T well below  $\Theta_D$ , as thoroughly documented in Reference 26. For  $T > \Theta_D$ , b reaches a plateau in most cases (32–34; see also **Figure 2** below), although some  $T^n$  (0 < n < 1) behaviors have been reported in a few instances (2, 35).
- **2.3.3. Interfacial bonding.** Finally, TBC is enhanced in materials pairs with strong interfacial coupling, which influences the transmission probabilities  $\alpha_{ij}$ . Although this is the most obvious mechanism influencing TBC, it is also by far the most challenging aspect to model accurately and control experimentally.

# 2.4. TBC for Phonons: Analytical Expressions for Interface Transmission Coefficients

MTL: maximum transmission limit of TBC (see Equation 11)

Phonons are the main contributors to TBC at dielectric/dielectric and metal/dielectric interfaces (theoretical arguments about electronic contributions in the latter are briefly discussed in Section 2.5.2). We focus on phonons in crystalline solids.<sup>1</sup>

The large majority of analytical TBC formulae developed over the years are generalizations of three well-established approaches (26): the AMM, the DMM, and attempts to bound the TBC from above [namely the RL and the maximum transmission limit (MTL)]. The essential distinction between these models is the transmission coefficient  $\alpha_{12}$  between the two materials.

**2.4.1.** Acoustic mismatch model. The AMM evaluates  $\alpha_{12}$  by solving the continuum elasticity equations for the acoustic transmission and reflection between two linear elastic solids (36). Because this approach ignores the granularity of the lattice, it is most appropriate for  $T \le 30$  K (26) so that long-wavelength phonons dominate the thermal spectrum. Each incident sound wave can be transmitted or reflected in six different ways (two longitudinal, four transverse) (37, pp. 311–43). Such complicated mode conversions are typically ignored, and the problem is simplified using expressions such as (36)

$$\alpha_{12}(\theta, p) = \frac{4 \frac{\rho_2 v_{p,2}}{\rho_1 v_{p,1}} \frac{\cos \theta_{p,2}}{\cos \theta_{p,1}}}{\left(\frac{\rho_2 v_{p,2}}{\rho_1 v_{p,1}} + \frac{\cos \theta_{p,2}}{\cos \theta_{p,1}}\right)^2},$$

where  $\theta_1$  and  $\theta_2$  are related through the acoustic analog of Snell's law,  $\frac{\sin \theta_1}{v_1} = \frac{\sin \theta_2}{v_2}$ , with the critical angle  $\theta_{1,\text{crit}} = \sin^{-1}(v_1/v_2)$  (assuming  $v_2 > v_1$ ).

Modifications of the AMM include a more complex treatment of sound waves (38) and taking into account weak interfacial bonding (39). Both of these modifications result in predicted b values lower than those resulting from the traditional AMM, which in turn predicts values well below those from experimental measurements at room temperature (2, 40).

**2.4.2. Diffuse mismatch model.** First proposed nearly 30 years ago, the DMM has been the most commonly used model to date (2, 40-42), albeit with mixed success. It postulates that all phonons impinging on the interface are scattered randomly, losing memory of their direction, polarization, and material of origin, keeping only their frequency  $\omega$  constant. After such scattering, the probability for a phonon to propagate into material i is proportional to that material's DOS at  $\omega$ . The DMM is thought more appropriate than the AMM at noncryogenic temperatures and for rough interfaces. This is because, at 300 K and up, the large majority of acoustic phonons have short wavelengths comparable to the interatomic spacing and surface roughness and can thus hardly see an interface as flat, as the AMM would require.

The DMM's postulate implies that the chances for a phonon incident from material 1 to transmit to material 2 are the same as those for a phonon from material 2 to be reflected at the interface. Thus,

$$\alpha_{ij}(\omega) = 1 - \alpha_{ji}(\omega).$$
 8.

Combined with the assumed DOS weighting of the outgoing phonon rates, Equation 8 means that the DMM is specified purely by the two surrounding materials' bulk dispersion relations.  $\alpha_{ij}(\omega)$  can then be found by applying Equation 8 to Equation 5 or 6. For example, for Debye solids at

<sup>&</sup>lt;sup>1</sup>We are unaware of any model for the TBC in amorphous materials that considers nonpropagating modes such as those introduced in Reference 163.

 $T \ll \min(\theta_{D,1}, \theta_{D,2})$  (26)

$$\alpha_{12} = \frac{\sum_{p} v_{p,2}^{-2}}{\sum_{p} v_{p,1}^{-2} + \sum_{p} v_{p,2}^{-2}}.$$

Among the many proposed extensions to the DMM are, most notably, the effect of interfacial reaction layers (43), the effect of interface roughening (44), and the effect of interfacial inelastic scattering (45). These treatments sometimes allow a good fit of specific results but, when exercised across a broader range of materials and interface types, have a predictive power that is limited at best.

**2.4.3.** Radiation and maximum transmission limits. The RL and the MTL were developed to assess upper limits to TBC. The RL (46) assumes that all the phonons coming from the side with the lower DOS at a given frequency have a transmission of 1. In the Debye approximation, this RL translates into

$$b_{\rm RL} = \sum_{p,2} \int_{\omega=0}^{\min(\omega_{\rm max})} \int_0^{2\pi} \int_0^{\pi/2} \frac{\hbar \omega^3}{8\pi^3 v_{p,\rm max}^2} \frac{\partial f}{\partial T} \cos(\theta) \sin(\theta) d\theta d\phi d\omega.$$
 9.

Note that the sum runs over the three polarizations of material 2, whereas the frequency integration extends only up to the maximum frequency of material 1. In the high-temperature limit, Equation 9 simplifies to (2, 47)

$$b_{\rm RL} = \frac{k_{\rm B}\omega_{\rm max,1}^3}{24\pi^2} \sum_{p,2} \left(\frac{1}{v_{p,\rm max}^2}\right).$$
 10.

The MTL (48) (equivalent to  $G_{\max}$  in Reference 49) is very much in the same spirit but uses the irradiance H (strictly speaking, its temperature derivative) and is generalized to allow perfect transmission of all phonons coming from the low- $\frac{\partial H}{\partial T}$  side (whether elastic or inelastic), hence setting the upper limit to h for any conceivable interfacial scattering process subject only to the restrictions of the first and second laws of thermodynamics. Assuming that the materials are labeled such that  $\frac{\partial H_1}{\partial T} \geq \frac{\partial H_2}{\partial T}$ , we see from Equations 3 and 5 that the MTL therefore sets  $\alpha_{21} = 1$  to yield simply

$$b_{\rm MTL} = \frac{\partial H_2}{\partial T}.$$
 11.

For example, at 300 K, Cu has  $\frac{\partial H_{\text{Cu}}}{\partial T} \cong 990 \text{ MW/(m}^2 \cdot \text{K)}$ , and diamond has  $\frac{\partial H_{\text{Dia}}}{\partial T} \cong 3,000 \text{ MW/(m}^2 \cdot \text{K)}$ . Thus the corresponding MTL TBC is  $h_{\text{MTL,Cu-Dia.}} = 990 \text{ MW/(m}^2 \cdot \text{K)}$ , limited by the phonon irradiance from the Cu side.

For a Debye model at high temperature, from Equation 7, this becomes:

$$h_{\text{MTL,Debye}} = \frac{1}{4} n_2 k_{\text{B}} \sum_{b} V_{s,2},$$

where  $n_2$  is the atomic number density of the low-H side and we use the DuLong-Petit heat capacity. The factor of 1/4 accounts for the angular integration of incident phonon velocities (26).

**2.4.4. Influence of the solid's dispersion relation.** The dispersion relations of the two materials clearly have a major influence on the calculated TBC. Because most models were originally developed using simple linear Debye models, some subsequent attempts have been made to incorporate more elaborate dispersion relations in models for  $H_i$  and  $\alpha_{ij}$ . Most notably, the DMM has been revisited with various dispersion relations, including exact lattice dynamics (50), simplified lattice dynamics (40), sine-type approximation (Born-von Karman) (48), truncated Debye (42),

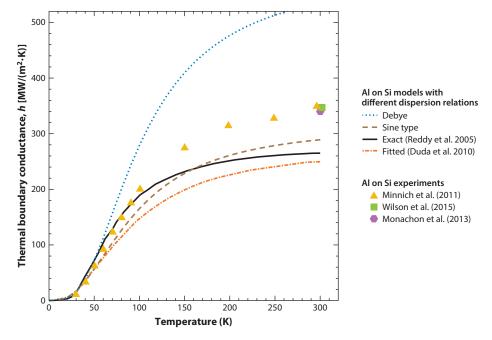


Figure 2

Effect of various dispersion relations on the diffuse mismatch model (DMM) for the thermal boundary conductance of a clean Al/Si interface. The experimental values (*yellow triangles*) are taken from Minnich et al. (32), showing excellent mutual agreement with room-temperature measurements from Monachon & Weber (34) (*purple hexagon*) and Wilson et al. (49) (*green square*). The DMM prediction using an exact phonon dispersion relation (*black line*) is taken from Reddy et al. (50). The prediction using a fitted <100> dispersion relation (*orange dashed-and-dotted line*) is taken from Duda et al. (51). The prediction using a sine-type dispersion relation (*brown dashed line*) is computed according to a classic, Born–von Karman treatment of a 1D chain (48). In the Debye model (*blue dotted line*), the maximum frequencies for longitudinal and transverse branches were calculated for both materials by using  $\omega_D = v_p (6\pi^2 n)^{1/3}$ , with n the atomic density, p the polarization, and v the sound velocity (52).

and fitted from measurements (51). **Figure 2** shows the influence of the dispersion relation on the DMM for an Al/Si system.

We note in passing that the DMM calculated using an exact dispersion relation fits the experimental data in **Figure 2** very well up to 100 K and falls short by only approximately 20–30% at higher temperatures. This is one of the most accurate TBC predictions using the DMM in the literature; many other DMM predictions fall only within a factor of 2 to 10 of the measured value.

#### 2.5. TBC for Electrons

Electrons are responsible for most of the transport of heat in metals (52). Although the heat capacity of metals is very limited—a few percent of the total heat capacity of most metals at ambient T—this limitation is outweighed by their high velocity. Most metals' Fermi velocities  $v_{\rm F}$  are of the order of  $10^6$  m/s, in contrast to phonon group velocities of the order of  $10^3$  m/s (52). Thus, in typical metals the  $C \cdot v$  product is significantly higher for the electrons than the phonons, which in light of Equations 5, 7, and 11 explains why the TBC of metal/metal interfaces is expected to be dominated by the electrons.

**2.5.1. Metal/metal interfaces.** The Landauer-Büttiker formalism presented in Equation 1 can be applied to an interface at which electrons dominate thermal transport, leading to the following electron irradiance  $H_e$  (53):

$$H_{e} = \frac{1}{2} \int_{0}^{\pi/2} \int_{0}^{\infty} E v_{F,1} N_{E,E_{F,1},T} \alpha_{12}(E) \cos \theta \sin \theta \, d\theta \, dE.$$
 12.

Here  $N_{E,E_{F,1},T} = (\exp((E - E_{F,1})/(k_B T)) + 1)^{-1}$  is the Fermi-Dirac function. From Equation 12, an MTL for electrons can be deduced as

$$b_{\rm MTL} = \frac{1}{4} v_{\rm F} \gamma_{\rm S} T, \qquad 13.$$

where  $\gamma_S$  is the material's Sommerfeld parameter (52). On the basis of this approach, Gundrum et al. (53) proposed an electronic version of the DMM that can be expressed as

$$h_{\rm el} = \frac{\gamma_{\rm S,1} v_{\rm F,1} \gamma_{\rm S,2} v_{\rm F,2}}{4(\gamma_{\rm S,1} v_{\rm F,1} + \gamma_{\rm S,2} v_{\rm F,2})} T.$$

This model gives accurate predictions in the case of Al/Cu (53) and Pd/Ir (1) metal/metal interfaces.

**2.5.2.** Dielectric/metal interfaces. Dielectric/metal interfaces impose two distinct challenges to an analysis of heat transfer. First, if one assumes that electrons do not contribute to TBC, a temperature difference can arise between the electrons and the phonons close to the surface (54). Although small, this effect may lead to errors in measuring dielectric/metal TBCs of the order of 500–1,000 MW/(m²·K) (33). More broadly, this effect is observed in any case in which heat is transported through the interface by low-heat-capacity thermal excitations that are weakly coupled with the phonons on each side of the interface (55). Such excitations could include electrons (e.g., metals), long-wavelength phonons (e.g., semiconductor alloys), and magnons.

Second, electrons on the metal side could conceivably pass some energy directly to phonons on the dielectric side of the interface. Proposed mechanisms include interaction with image charges in the dielectric (56). However, experiments by Stoner & Maris (40) and Lyeo & Cahill (2) show that a 400-fold change in electronic density for otherwise similar metals (Bi and Pb) on the metal side of the interface does not significantly impact TBC, which is a strong argument against any such effect.

#### 2.6. Computational Approaches

Computing thermal transport properties has gained substantial credibility in the past 20 years, thanks mainly to an increase in computing power and to the development of better simulation techniques (57). All computational techniques require three main inputs: a heat transport–solving algorithm, an interatomic potential, and a data extraction method. Each input impacts the final result, and their limitations should be known. Three main types of computational models have been used to describe TBC: (a) molecular dynamics (MD) simulations, (b) reciprocal-space models, and (c) Green's function formalisms. Among these, at present only MD can treat systems with interfacial structures close to reality; the other two need idealized settings such as perfectly epitaxial materials. Additional references for the computational issues discussed below are provided in **Supplemental Table 1** (follow the **Supplemental Material link** from the Annual Reviews home page at **http://www.annualreviews.org**).

Supplemental Material

**2.6.1. Interatomic potentials.** Because many techniques use empirical interatomic potentials such as Lennard-Jones or Stillinger-Weber, any new user should bear in mind that these potentials

are fit to reproduce only a subset of a material's properties, e.g., its bulk modulus and the size of its primitive unit cell. Calculating other properties is an extrapolation prone to potential artifacts. Density functional theory (DFT) and related methods (58, 59) are a significant step forward but very costly computationally. Moreover, except if calculated using DFT, the nature of a bond can vary wildly at an interface, and the bonding to a different material can significantly influence the behavior of the few atomic layers surrounding the interface. Instructive literature examples can be found in Reference 60 for the diamond/metal interface and Reference 61 for an Al/Al<sub>2</sub>O<sub>3</sub> interface in which bonds that are a hybrid between metallic (on the Al side) and ionic (on the Al<sub>2</sub>O<sub>3</sub> side) form in the last Al atomic layer. In both of these examples, an empirical potential would fail exactly where it needs to be most accurate: at the interface. Thus, one should be extremely cautious when studying real systems beyond the idealized Si/Ge interface.

**2.6.2. Classical molecular dynamics methods.** MD methods use a system typically composed of several thousands of atoms with a given interatomic potential. Atomic motion is governed by simple equations of motion and follows Maxwell-Boltzmann classical statistics, limiting MD methods to  $T > \theta_D/3$  (57). Temperature in MD is calculated by equating the local energy of the atoms to  $k_BT$ , which requires large simulation cells (62). Two main approaches, nonequilibrium MD (NEMD) and equilibrium MD (EMD), are used.

NEMD is typically characterized by hot and cold thermal reservoirs on either side of the simulation cell containing the interface of interest. Temperature is calculated over the length between the heat source and sink, and the interfacial temperature drop is extracted (63).

EMD can be used to determine thermal properties by looking at fluctuations of atomic energy around the equilibrium. TBC can be extracted using, e.g., the Green-Kubo formula (62).

Both MD techniques are relatively simple to implement and are useful for insights into general trends. Both require large supercells to minimize size effects (64) and a large number of time steps to ensure that the system is thermalized. NEMD techniques typically impose very high temperature gradients ( $\sim 10^9$  K/m), which may cause thermal transport to no longer be in a linear regime. EMD simulations inherently do not show that behavior but require longer simulation times (62), which can significantly change results (65).

**2.6.3. Reciprocal-space models.** Reciprocal-space models directly consider the phonons present in the two materials in contact. This approach has been used in two ways: (*a*) lattice dynamics simulations (33, 40, 66) and (*b*) wave packet transmission calculations (67, 68).

In lattice dynamics calculations, the two materials in contact are described by their structure and an interatomic potential, phonons of bulk dispersion are randomly generated in each material's first Brillouin zone, and continuity equations are applied at the interface. TBC can be deduced using the Landauer-Büttiker formalism presented in Equations 4 and 5.

Wave packet transmission calculations rely on a hybrid between a real-space approach and a reciprocal-space approach. These calculations consist of constructing an interface structure in real space, generating a wave packet at one end of it, and measuring the fraction of the wave packet that is transmitted through the interface (thereby bringing the analysis back into reciprocal space). This method provides a direct insight into the transmission coefficient but neglects phenomena related to phonon focusing (31) if not applied for a significant number of interfaces with various orientations or wave packet directions.

**2.6.4. Atomistic Green's function.** The Green's function formalism is a general method widely used in physics and applied mathematics to reduce complex problems involving differential equations to more tractable integral solutions. The goal of using Green's function is to calculate a harmonic matrix solution for the frequency- and/or wave vector-dependent interface transmission

properties. The full mathematical treatment for TBC and its advantages and limitations are reviewed in depth in Reference 69. Examples of application to TBC calculations in harmonic systems can be found in References 70 and 71. Anharmonic interactions can be taken into account only in simple systems (72). Inputs to this method are atomic masses and bonding strengths. A special class of these functions termed first-principles atomistic Green's functions uses DFT-calculated force constants (73), permitting hope for quantitatively accurate results. In general, this treatment is well suited for ballistic transmission calculations, i.e., low-dimensional or low-temperature systems. Whereas the latter condition is not always fulfilled, the former may be for an interface, as in its simplest expression it consists of a spring connecting the two reservoirs. Thus, atomistic Green's functions can be used at higher temperatures if no inelastic interactions are assumed (69). The Green's function approach grows substantially in complexity as more degrees of freedom are added for the atoms, which means that low-dimensional (1D and 2D) systems are preferred (71).

#### 3. METHODS TO MEASURE TBC

Here we survey the five main experimental methods used to measure TBC. Schematics of these methods are given at the top of **Figure 3**, and at the bottom of **Figure 3** are maps of each method's sensitivity to TBC, discussed in detail below.

#### 3.1. Cut-Bar Method

If the materials on either side of the interface are extremely conductive and the TBC very low, TBC can be measured with a simple cut-bar method. In practice, this high-*k* requirement restricts

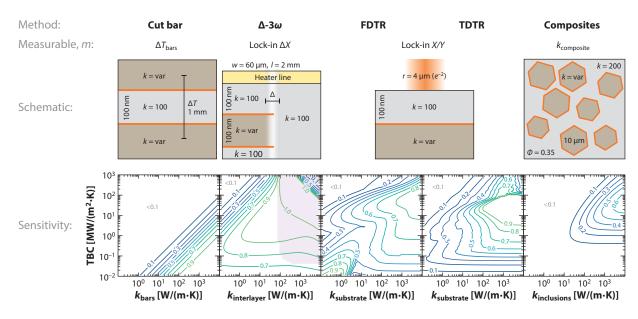


Figure 3

Overview of the five main experimental methods used to measure thermal boundary conductance (TBC) and their sensitivities. (*First row*) General name of the technique. Abbreviations: FDTR, frequency-domain thermoreflectance; TDTR, time-domain thermoreflectance. (*Second row*) The raw measurable, m, for which the sensitivity is evaluated. (*Third row*) Schematics, with the relevant TBC layers in orange. (*Bottom row*) Calculated sensitivity (contours of constant  $S_b^m$ ; see Equation 20) of each technique's measurable to b. These maps are expressed as functions of two variables: b and b of the component indicated as b are in each schematic (*brown phase*).

the method to cryogenic measurements, e.g., in the In/sapphire system (74). At such temperatures, however, the mean free path of energy carriers can become comparable to the characteristic dimensions of the cut bars themselves, requiring careful thermocouple placement to avoid artifacts (26).

#### 3.2. Thermally Modulated Methods

Because TBC is restricted to an interface, methods capable of probing very small volumes are required. A widely exploited strategy is to use transient heating at short timescales,  $t_{char}$ , to control and minimize the thermal penetration depth

$$d_{
m th} \sim \sqrt{rac{k}{C}t_{
m char}},$$
 14.

where k is the thermal conductivity and C the volumetric heat capacity. Localizing the thermal excitation and response to only the immediate vicinity of an interface makes the experiment more sensitive to TBC. This key insight is the basis of the three major TBC experimental schemes used today and described next: the electrothermal  $3\omega$  method and optical methods based on time- and frequency-domain thermoreflectance (TDTR and FDTR, respectively).

**3.2.1.**  $3\omega$  and related electrothermal methods. This family of techniques uses a microfabricated metal strip to locally heat a dielectric substrate and uses the same or another nearby strip to measure the temperature response (26, 75). The most prominent variant is the  $3\omega$  method (75, 76), which uses an ac current at a frequency  $\omega$  for heating, with the third harmonic voltage giving information about the thermal properties. Although applied primarily to measure k of bulk substrates and thin films, in certain regimes the  $3\omega$  method is also sensitive to the TBC between the heater line and substrate (77–79).

In practice, the  $3\omega$  method is limited to frequencies  $\omega/2\pi$  below  $\sim 10$ –100 kHz, thereby placing a lower bound on  $d_{\rm th}$  (14) and limiting the maximum TBC that can be detected. This method requires careful experimental design. A thin film is often incorporated between the substrate and heater line, so there are two relevant TBCs in series. The substrate should have high k. In one approach, the thermal response is measured as a function of the film thickness (whose k must remain constant), allowing for a subsequent separation between interface and bulk contributions (77, 80). If the intervening thin film is sufficiently thin and conductive ( $d_{\rm film} \cdot b \ll K_{film}$ ), the simpler differential  $3\omega$  method, which compares a pair of measurements with and without the film, may be used (77, 80, 81).

**3.2.2. Pump/probe thermoreflectance techniques.** Pump/probe thermoreflectance techniques (thoroughly reviewed in Reference 82) are by far the most common for measuring TBC. Their core principle is to heat a 50–200-nm-thick metal layer on top of a substrate by using a modulated laser beam (the pump) while using another laser beam (the probe) to detect temperature through its effect on the metal's reflectance. Thermal models are then used to fit the obtained signal for one or more thermal properties of the system. The two main variants are FDTR and TDTR, and the results can be transformed between the two domains (83). In both variants, in contrast to the  $3\omega$  method, it is common practice to use both the in-phase (X) and out-of-phase (Y) signals recorded by the lock-in amplifier, usually by plotting the phase angle  $\phi = \tan^{-1} \frac{Y}{X}$  or, more directly, the  $\frac{X}{Y}$  ratio (33, 82).

In FDTR (84–86), both lasers are continuous wave (CW), with the pump modulated at various frequencies. Compared to the ultrafast lasers used in TDTR, the CW lasers used in FDTR are cheaper and have greater wavelength flexibility but can be noisier. The optical alignment is simpler,

except at very high frequencies (which can reach 200 MHz), which require matching the pump and probe path lengths to avoid residual phase errors.

In TDTR (82, 87, 88), both lasers are pulsed, with pulse width of 0.1–10 ps [using polymer dye lasers (40), Ti:sapphire lasers (2), or Nd:YAG ultrafast lasers (14)]. The pump is modulated at a single frequency to enable lock-in detection of the probe signal. Results are extracted by fitting curves of the probe signal as a function of the pump/probe delay time.

Alternative pump/probe techniques have also been used to investigate TBC. Siemens et al. (89) used a soft-X-ray probe's diffraction from nanofabricated Ni gratings to measure its TBC with SiO<sub>2</sub> and sapphire. Highland et al. (90) used X-rays to monitor the [004] diffraction peak of GaAs, to deduce its lattice temperature, and to obtain its TBC with the neighboring Al layer. Finally, Hanisch-Blicharski et al. (91) measured TBC at a Bi/Si interface by using the Debye-Waller factors of the Bi diffraction peaks.

#### 3.3. Effective Thermal Conductivity of Micro/Nanocomposites

Another method to measure TBC comes from composites with high- $k_i$  inclusions in a low- $k_{\rm m}$  matrix (15). In these materials, a finite TBC reduces the overall k, an effect that can be used to measure it. Because this method has not been reviewed elsewhere, we give some details here. We begin with the theoretical basis of the TBC-extracting procedure, followed by examples of its application in the literature and a discussion of some of the associated difficulties. We conclude with a comparison of TBC values obtained using this inverse method as compared to direct methods such as TDTR.

**3.3.1. Theoretical background.** Many models for calculating the effective composite thermal conductivity  $k_{\text{composite}}$  have been developed over the last 150 years (92, pp. 435–49; 93; 94) and are nicely summarized in References 95–98. Models were developed for random arrangements of spherical particles but can be extended to spheroidal and ellipsoidal particles.

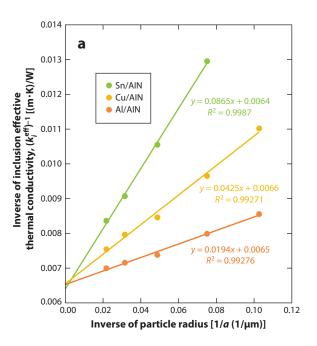
Although most models were originally developed for perfect conduction through the inclusion-matrix interfaces ( $h = \infty$ ), the effects of TBC can also be included (99–101). The key theoretical result is that, for spheres, adding a finite TBC to an inclusion with intrinsic  $k_i^{\text{int}}$  leads to the same heat flow pattern as a spherical inclusion without TBC but using a modified effective conductivity,  $k_i^{\text{eff}}$ :

$$k_i^{\text{eff}} = \frac{k_i^{\text{int}}}{1 + \frac{k_i^{\text{int}}}{h_a}},$$

with a the radius of the inclusion. Thus,  $k_{\text{composite}}(k_i^{\text{int}}, h) \to k_{\text{composite}}(k_i^{\text{eff}}, h = \infty)$ , allowing use of the numerous  $k_{\text{composite}}$  models that assumed perfect interfaces. Equation 15 can also be used to extract the thermal conductance of grain boundaries for grains larger than the mean free path of the material's heat carriers (102).

For spheroidal inclusions, the situation is less straightforward. However, for moderate contrast in k (i.e.,  $k_i^{\text{eff}}/k_{\text{m}} < 5$ ), and moderate spheroid aspect ratios (i.e., <5), for  $k_{\text{composite}}$  calculations it is a reasonable approximation to replace randomly oriented spheroids with perfect spheres of the same hydraulic diameter, i.e., the same particle volume. We also note that, because the models described above are continuum models, they do not account for the reduction of  $k_i^{\text{int}}$  in particles smaller than the intrinsic phonon mean free path [typically a concern only for a smaller than  $\sim$ 1–10  $\mu$ m (103)].

**3.3.2.** Extraction procedures for TBC. The extraction of TBC from composite data is known as the inverse problem (104). Obtaining TBC from composite thermal conductivities can be achieved either through an implicit procedure, i.e., directly fitting a set of composite k for TBC (104–107),



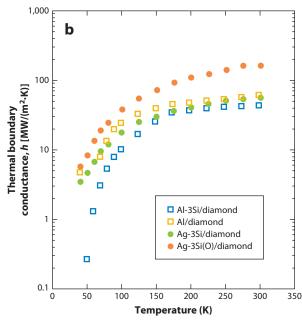


Figure 4

(a) Graphical extraction of thermal boundary conductance (TBC) by plotting the effective thermal conductivity of AlN inclusions, extracted from  $k_{\text{composite}}$  using a differential effective medium scheme, as a function of the inverse of the equivalent particle radius. The slope of the linear fit is 1/b, and the intercept gives  $(k_i^{\text{int}})^{-1}$ . Experimental data for AlN particles in various matrix metals from Kida et al. (18). (b) TBC extracted from composites with different matrix alloys and four different particle sizes by using Equation 15. The characteristic decrease in TBC below 300 K is consistent with theory and other techniques of TBC measurement (e.g., **Figure 2**). Data compiled from Edtmaier et al. (108, 109).

or through explicit extraction of the effective thermal conductivity of the inclusion (108–111). Rearranging Equation 15 gives

$$\frac{1}{k_i^{\text{eff}}} = \frac{1}{k_i^{\text{int}}} + \frac{1}{b} \frac{1}{a}.$$
 16.

Hence, plotting  $(k_i^{\text{eff}})^{-1}$  against  $a^{-1}$  should yield a line of slope  $b^{-1}$  and an intercept at  $a^{-1} = 0$  of  $(k_i^{\text{int}})^{-1}$ . This procedure has been successfully applied in, e.g., M (M=Al, Cu, Sn)/AlN systems (18) and M (M=Al, Al-Si, Ag, Ag-Si)/diamond systems (108, 109), with representative data in **Figure 4**.

A related approach (112, 113) determines the critical inclusion size,  $a_{\text{crit}}$ , at which  $k_{\text{composite}} = k_{\text{m}}$  (114). Setting  $k_{\text{m}} = k_{\text{i}}^{\text{eff}}$  and  $a = a_{\text{crit}}$  in Equation 15 leads to

$$b = \frac{1}{a_{\text{crit}}} \frac{k_i^{\text{int}} k_{\text{m}}}{k_i^{\text{int}} - k_{\text{m}}}.$$

Given measurements of  $k_{\text{composite}}$  as a function of a for a fixed particle volume fraction, the point at which  $k_{\text{composite}} = k_{\text{m}}$  determines  $a_{\text{crit}}$ , and thus b, from Equation 17.

- **3.3.3. Challenges in extracting TBC from composite data.** It is becoming customary in the composite literature to report TBC of matrix/inclusion couples extracted from  $k_{\text{composite}}$ , sometimes even from single experiments. The uncertainties of such a procedure are, however, significant:
  - A 1–3% uncertainty lies in the measurement of  $k_{\text{composite}}$ , which can easily translate into a 3–5% uncertainty in  $k_i^{\text{eff}}$ .

- Uncertainty in  $k_i^{\text{eff}}$  is introduced by the uncertainty in composite parameters, e.g., matrix thermal conductivity, inclusion volume fraction, and the presence of pores. This uncertainty can be alleviated by concomitant density and matrix electrical conductivity measurements (see, e.g., References 111 and 115), but samples containing more than 1-vol% porosity should be avoided altogether.
- Different modeling schemes give differing results for  $k_{\text{composite}}$ . The often-used formula proposed by Hasselmann & Johnson (116), an explicit form of the Maxwell-Garnett mean field scheme, overestimates the effective thermal conductivity for insulating inclusions (20, 117). In cases of large phase contrast,  $k_i^{\text{eff}}/k_{\text{m}} > 4$ , the differential effective medium scheme should be used instead (20).

Once the effective  $k_i^{\text{eff}}$  is obtained, the effects of the uncertainty in the intervening parameters on the uncertainty in the extracted b can be assessed. Rearranging Equation 1 to isolate b and taking the total differential as the uncertainty on TBC,  $\Delta b$ , we find

$$\Delta b = \left| \frac{k_i^{\text{int}} k_i^{\text{eff}}}{\left(k_i^{\text{int}} - k_i^{\text{eff}}\right)^2} \frac{1}{a^2} \right| \Delta a + \left| \frac{\left(k_i^{\text{eff}}\right)^2}{\left(k_i^{\text{int}} - k_i^{\text{eff}}\right)^2} \frac{1}{a} \right| \Delta k_i^{\text{int}} + \left| \frac{\left(k_i^{\text{int}}\right)^2}{\left(k_i^{\text{int}} - k_i^{\text{eff}}\right)^2} \frac{1}{a} \right| \Delta k_i^{\text{eff}}.$$
 18.

Again, upon rearranging Equation 15 to eliminate the  $(k_i^{int} - k_i^{eff})$  terms and inserting the result into Equation 18, we find the relative error on TBC to be

$$\frac{\Delta b}{b} = \left| \frac{\Delta a}{a} \right| + Bi \left| \frac{\Delta k_i^{\text{int}}}{k_i^{\text{int}}} \right| + \frac{Bi^2}{Bi + 1} \left| \frac{\Delta k_i^{\text{eff}}}{k_i^{\text{eff}}} \right|,$$
 19.

with Bi the Biot number of the inclusion given by  $ha/k_i^{\text{int}}$ .

Hence, for Bi < 1, i.e., for strong influence of interfaces, the main source of error in b comes from the relative uncertainty in inclusion size a (118). For Bi > 10, uncertainties in the intrinsic properties of the inclusions  $k_i^{\text{int}}$  are dominant. This is particularly important for industrially produced diamond, cBN, and SiC, as deviation from stoichiometry (cBN, SiC) and impurities (mainly nitrogen in synthetic diamond) lead to significant uncertainty in  $k_i^{\text{int}}$  (119, 120).

**3.3.4. Comparison of direct and indirect determination of TBC.** The indirect method of extracting TBC has been applied mainly to metal/dielectric combinations motivated by thermal management applications, e.g., Al/SiC (104, 110–112, 115), (Cu, Ag, Al, ZnS, cordierite)/diamond (16, 20, 108, 112, 121–123), and (Cu, Al)/AlN (18). Virtually all the cited references give TBC around room temperature; the exceptions are Hasselmann and colleagues (115, 124) for the diamond/cordierite and Al/SiC systems and Edtmaier et al. (108, 109) for several metal/diamond systems shown in **Figure 4**.

**Table 1** compares the composite TBC extraction scheme and TDTR on equivalent systems. A more complete table of TBC values can be found in **Supplemental Table 2**.  $h_{\text{comp}}$  is within 20–30% of  $h_{\text{TDTR}}$  in every case. This is noteworthy considering that the composites' synthesis route

Supplemental Material

Table 1 Comparisons of TBC determined from direct (TDTR) and indirect (composite) methods, for couples of Al on SiC, AlN, and hydrogen-terminated diamond

Couple	$b_{\text{comp}} [\text{MW/(m}^2 \cdot \text{K})]$	$b_{\rm TDTR} \ [{\rm MW/(m^2 \cdot K)}]$
Al/SiC	146 (125), 140 (111), 220 (115),180 (104)	200 (42)
Al/AlN	50 (18)	47 (126)
Al/C:H	62 (108), 5–45 (123)	32–65 (127), 22 (128)

involves very high temperatures, which can significantly change the interface's nature compared with interfaces created in thin-film deposition.

#### 3.4. Comparison of the Sensitivities of the TBC Measurement Methods

To summarize the relative strengths and practical operating regimes of the five major experimental methods presented above, **Figure 3** presents calculations of each method's sensitivity to TBC, using realistic properties and geometries. The sensitivity S of measurable m to parameter p is

$$S_p^m = \frac{\partial \ln(m)}{\partial \ln(p)} = \frac{p}{m} \frac{\partial m}{\partial p},$$
 20.

where we focus on p = b and the relevant m for each method is specified in **Figure 3**. This comparison gives helpful insights into which method to use in which case. For a more complete understanding, the selectivity—i.e., the ability of the technique to discriminate between, e.g.,  $k_{\text{sub}}$  and b—should also be considered. Moreover, the uncertainty in  $k_{\text{sub}}$  can propagate into errors in b through  $\left(\frac{\Delta b}{b}\right) = \left(\frac{S_{k_{\text{sub}}}^m}{S_b^m}\right)\left(\frac{\Delta k_{\text{sub}}}{k_{\text{sub}}}\right)$  (129). Some specific observations from **Figure 3** follow.

- TDTR and FDTR are the most versatile methods, with TDTR being more sensitive for a wide range of intermediate h. By having access to both time and frequency information, TDTR has in general a better selectivity to h than does FDTR (details not shown in Figure 3). As a side note, TDTR also has the benefit of measuring thermal transport as fast as the subnanosecond timescale, corresponding to GHz frequency bandwidth, in contrast to 200 MHz and less for FDTR.
- The differential  $3\omega$  method is appropriate for measurements of moderate to low b and high  $k_{\text{sub}}$ . For some  $k_{\text{interlayer}}/b$  combinations, the effective thermal conductivity of the variable-k film (including its TBCs) matches that of the substrate material. In this special case  $|S_b^{\text{Lock-In}\,\Delta X}| \to \infty$ , but this regime is impractical because the  $3\omega$  voltage difference  $\Delta X$  vanishes and is thus overwhelmed by noise. To exclude this artifact, a shaded area was overlaid on **Figure 3** where  $\Delta X$  is expected to be less than 1  $\mu V$ .
- The composite approach [using the recommended (20) differential effective medium model] is sensitive to TBC when the inclusions conduct heat at least as well as the matrix ( $\Phi k_i^{\text{eff}} \ge k_{\text{m}}$ , where  $\Phi$  is the volume fraction of particles), and requires TBC to not screen the inclusions, resulting in  $b \sim k_i^{\text{int}}/a$  for maximum sensitivity.
- The cut-bar method is valid only for high  $k_{\text{bars}}$  and low b, consistent with cryogenic temperature measurements (26).

#### 4. MAIN FACTORS EXPERIMENTALLY PROVEN TO INFLUENCE TBC

We conclude this review by summarizing high-quality TBC measurements from the literature, interpreted using the framework established in Section 2. With reference to **Figure 1**, the two essential materials science considerations are the carrier irradiances,  $H_i$ , and the interface transmissivities,  $\langle \alpha_{ij} \rangle$ . Sections 4.2 and 4.5 focus on the effects of phonon dispersion relation on H, whereas Sections 4.3–4.8 deal with the effects of interfacial bonding and quality on  $\langle \alpha \rangle$ .

#### 4.1. Benchmarking

The TBC between Al and clean sapphire has been measured by a number of investigators (34, 35, 40), with good convergence around  $b = 185 \pm 15$  MW/(m<sup>2</sup>·K) at 300 K. This system is particularly suitable for benchmarking because sapphire is commercially available with very low surface

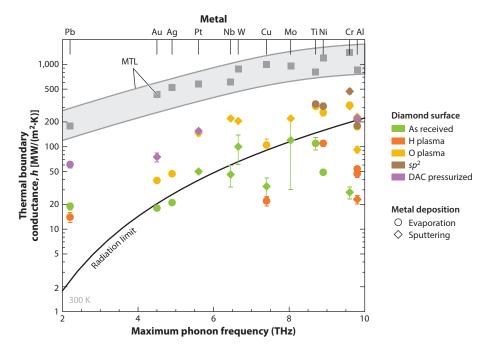


Figure 5

Collected experimental results for the thermal boundary conductance (TBC) between diamond and 12 different metals. The bottom axis gives the maximum phonon frequency of the metal (collected from http://materials.springer.com/), whereas the specific corresponding metals are indicated by the ticks along the top axis. Point color and shape indicate surface treatment and metal deposition technique, respectively. For modeling context, the black line is the radiation limit (Equation 10), and the gray squares and gray-shaded band show the maximum transmission limit (MTL) (Equation 11). The available error bars indicate standard deviation over repeated measurements. Diamond anvil cell (DAC)-pressurized values from Reference 130, Pb/diamond values from Reference 2, and the lowest H and O plasma Al/diamond values from Reference 128. Other values from References 34, 47, 127, and 131–133.

roughness, is easily cleaned by baking in air at high T, and does not react with Al. The Al/Si couple has also been widely studied. Although the interfacial quality is harder to control, measurements for the highest-quality interfaces cluster around  $b = 345 \pm 40 \text{ MW/(m}^2 \cdot \text{K})$  at 300 K (**Figure 2**) (32).

#### 4.2. Dispersion Relation and Acoustic Contrast

One important trend of the experimental literature is that high dissimilarity between the phonon properties of two materials is consistently found to yield low TBC. Such results have traditionally been presented and interpreted in terms of the contrast between the materials' Debye temperatures or, equivalently, their maximum phonon frequencies, such as the results collected in **Figure 5** for various metals on diamond. The  $\theta_D$  ratios can be large, exceeding 10:1 in couples pairing dense, soft metals like Bi, Pb, and Au ( $\theta_D = 95$ , 102, and 165 K, respectively) with diamond ( $\theta_D = 2,240$  K) (2, 40) or graphite (134, 135). The RL picture holds for most systems at cryogenic temperatures [lower than approximately ( $\theta_{D,min}/10$ )], where the AMM shows excellent results (see Reference 26 and references therein). However, at room temperature, as shown in **Figure 5** the correlation between  $\theta_{D,min}$  (indicated by the  $\omega_{max}$  axis) and TBC is modest at best, with the interfacial quality

having a larger influence in most cases, as discussed further in Section 4.3. **Figure 5** also shows that the MTL is better than the RL as an upper bound and for describing the observed experimental trends, suggesting that inelastic interfacial scattering processes are important at room temperature and above.

**Figure 6** is the most comprehensive of this review, summarizing TBC measurements for 34 distinct couples with high-quality interfaces; these measurements were collected from 19 primary

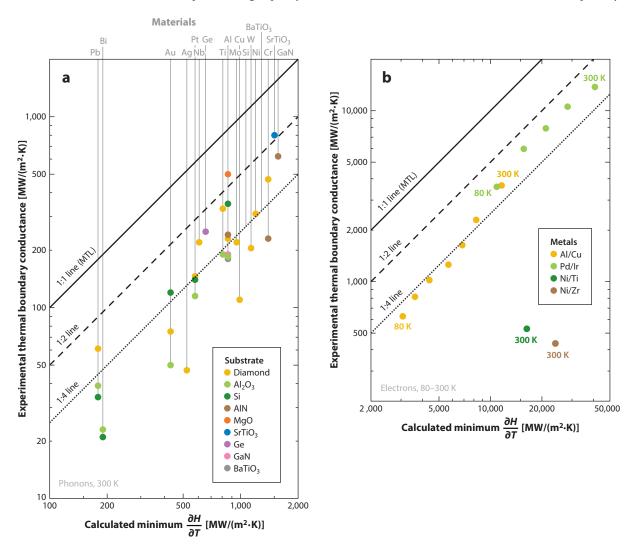


Figure 6

Collected experimental thermal boundary conductance (TBC) values for systems dominated by (a) phonons and (b) electrons, organized to compare with the minimum irradiance framework (Equations 5 and 11). Each point in panel a represents a unique materials pair: In analogy to **Figure 5**, the material with the weaker  $\frac{\partial H}{\partial T}$  locates the point along the bottom axis (with the specific material indicated by the corresponding ticks along the *top axis*), whereas the material with the stronger  $\frac{\partial H}{\partial T}$  is encoded by the point color. The 1:1 line corresponds to the maximum transmission limit (MTL), i.e.,  $\alpha_{\min \to \max} = 1$ , with the other two lines corresponding to  $\alpha_{\min \to \max}$  of  $\frac{1}{2}$  and  $\frac{1}{4}$ . Panel b also includes temperature-dependent data below 300 K. Phonon data are from References 2, 18, 32–34, 40–41, 47, 49, 127, 130, 131, 133, 136, and 137. Electron data are from References 1, 53, and 138).

references. For both phonons and electrons, the dominant trend is that the measured b correlates with the irradiance temperature derivative (48, 49) from the weaker side, consistent with the physical picture established in **Figure 1**. Using  $\left[\frac{\partial H}{\partial T}\right]_{\min}$  as the x-axis is advantageous because  $\left[\frac{\partial H}{\partial T}\right]_{\min}$  depends only on the dispersion relation of a single material and makes no assumptions about the detailed transmission physics of  $\alpha$ . The 1:1 line is the MTL, corresponding to  $\alpha_{\min \to \max} = 1$  and  $b = \left[\frac{\partial H}{\partial T}\right]_{\min}$ . **Figure 6** shows that the large majority of available experiments on high-quality interfaces can be understood in terms of the minimum irradiance picture; the corresponding average transmission coefficients  $\langle \alpha_{\min \to \max} \rangle$  are in the range of 0.1–0.5, the details of which are discussed next.

DAC: diamond anvil

**SAM:** self-assembled monolayer

#### 4.3. Interfacial Bonding Strength and Stiffness

The phonon transmission coefficients  $\alpha$  depend critically on the atomic-scale details of the interfacial bonding and can vary widely in real interfaces (factors of 5 or 10 are not uncommon), depending on how exactly the surface was prepared. Indeed, as illustrated schematically in **Figure 1***a*, the detailed structure of the interface can dramatically impact TBC, be it through an interfacial layer [whether interdiffused (16, 43, 133, 139) or deliberately added (10, 140–142)], its roughness (44, 143), or simply the substrate's chemical termination (18, 34, 128).

Using the diamond/metal system as an example, **Figure 5** demonstrates the strong impact that the details of the interface formation process can have on the experimental TBC. TBC is significantly lower for interfaces on as-received diamonds. This reduction is caused by poor adhesion (132) due to organic residues (34). Similarly, films made by sputtering, a process that promotes adhesion (144), tend to have higher TBCs with clean diamond than do their evaporated counterparts (127). Finally, subjecting metal/diamond interfaces to hydrostatic pressures above 10–20 GPa [see the diamond anvil cell (DAC) points in **Figure 5**], thought to enable bondenhancing chemical reactions, leads to the highest TBCs for any given system (130).

Electron-dominated-TBC results are also highly sensitive to interface quality. The much lower TBCs seen for the Ni/Zr and Ni/Ti couples in **Figure 6***b* can be explained by the fact that those systems can react together to form intermetallic phases, thereby precluding the existence of abrupt, high-quality interfaces and thus decreasing  $\langle \alpha \rangle$ .

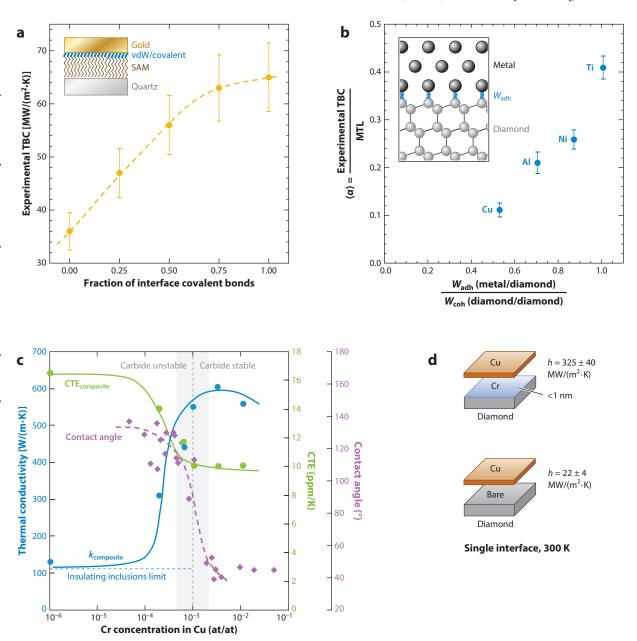
**Figure 7** presents four experimental examples highlighting the strong impact of interfacial bonding on b through  $\alpha$ . **Figure 7**a shows a compelling example using the TBC between a quartz substrate and a transfer-printed gold layer, which sandwich a self-assembled monolayer (SAM) of variable bonding strength (140). Increasing the density of covalent bonds between the SAM and the gold improves the TBC between gold and quartz by nearly a factor of 2, which also exhibits a physically satisfying correlation with improved adhesion as measured using a laser spallation method. Additionally, incorporating a Ti adhesion layer between Al and graphite approximately doubles the measured TBC (10). A similar enhancement has been observed with a Ti adhesion layer for the gold/SiO<sub>2</sub> TBC (146).

Figure 7b shows how the work of adhesion ( $W_{\rm adh}$ ) of a metal/diamond interface can be linked to its TBC. This is clearly illustrated by normalizing each measured TBC to the corresponding MTL calculation ( $b_{\rm MTL} = \left[\frac{\partial H}{\partial T}\right]_{\rm min}$ ), thereby giving  $\langle \alpha_{\rm min \to max} \rangle$ . The clear trend is  $\langle \alpha_{\rm min \to max} \rangle$  increasing with  $W_{\rm adh}$ , which correlates with the interfacial bonding stiffness.

Similar effects of adhesion on TBC are well known for MMCs (16, 123, 147, 148). In particular, because Cu and Ag bond weakly to diamond, incorporating a bond-strengthening metallic carbide at the interface has become quite standard. **Figure 7**c provides an exemplary case study of this approach. Adding small quantities of Cr to the Cu matrix causes Cr carbide formation for concentrations above  $\sim 10^{-3}$  Cr/Cu. This carbide dramatically improves the

CTE: coefficient of thermal expansion (ppm/K)

adhesion between Cu and diamond, and this improvement is independently seen through decreased coefficient of thermal expansion (CTE) [diamond ( $\sim$ 1 ppm/K) having a much lower CTE than Cu ( $\sim$ 17 ppm/K) (16)] and in the reduced Cu/diamond contact angle. This improved adhesion also dramatically increases  $k_{\text{composite}}$  more than fivefold, which, through the use of Equation 16, can be understood as the Cu/diamond TBC increasing from  $\sim$ 0.5 to 70 MW/(m²·K) due to the bridging interfacial carbide. **Figure 7d** further confirms this striking interfacial effect by comparing TDTR measurements of two Cu/diamond samples, with one diamond as received and the other diamond terminated with an ultrathin (<1-nm) Cr carbide layer showing a 15-fold



increase in TBC. Similarly large interfacial effects have also been observed in Al/diamond MMCs. For example, estimating the TBC by using  $k_{\text{composite}}$  data from Reference 147 suggests an Al/diamond TBC that varies  $\sim$ 100-fold as the interfacial adhesion is improved by changing the production process to promote stronger interfacial bonding (123).

#### 4.4. Finite-Thickness Interfacial Interlayers

Interfacial layers between matrix and inclusions in MMCs can be crucial for good bonding and efficient heat transfer between matrix and inclusions (148, 149). However, their chemical nature, crystallinity, and thickness may affect TBC as well. No significant impact was found (beyond the added resistance of the layer itself) of an amorphous  $Al_2O_3$  (141) or a carbide (133) interlayer between metals and diamond, suggesting that a reaction layer could be present even in nominally pristine interfaces and could influence the behavior of these interfaces. MD studies also suggest that adding an interlayer with acoustic properties that transition between two otherwise mismatched materials can improve the thermal transport between them (150, 151). Conversely, increasing the thickness of a silicide interlayer from 10 to 15 nm in a Cr/Si system was measured to degrade its TBC by  $\sim$ 40% (152).

#### 4.5. Substrate Anisotropy

All crystalline solids exhibit anisotropy in their phonon dispersion relation, causing their H to vary with direction. Such phonon-focusing effects are expected to influence TBC and would help explain (31) the very low TBCs [ $\sim$ 10–100 MW/( $\rm m^2 \cdot K$ )] observed between metals and c-axisoriented graphite (10, 135). **Figure 8** summarizes the limited available data that directly compare TBC on two different crystal faces with otherwise identically prepared interfaces. For Si (cubic symmetry), no significant difference between <100>-oriented substrates and <111>-oriented substrates was observed for three different metals. A modest orientation effect was observed in the Al/sapphire TBC, attributed to sapphire's anisotropic crystal structure. However, **Figure 8** should not be interpreted as ruling out strong orientation effects even for these substrates because, for all the couples presented, the TBC-limiting irradiance  $\left[\frac{\partial H}{\partial T}\right]_{\min}$  is actually from the metal side, so these data are only weakly sensitive to the directionality of H from the substrate side. Lastly, the strongest apparent anisotropy effect in **Figure 8** is for the Al/diamond system when the diamond is terminated with hydrogen (127). However, this effect is explained not by an H anisotropy of

Figure 7

Representative experimental results showing the effects of adhesion on increasing  $\langle \alpha \rangle$  and thus thermal boundary conductance (TBC). (a) Measurements by Losego et al. (140) show the impact of increasing the proportion of covalent versus van der Waals (vdW) bonds at a gold/quartz interface linked using self-assembled monolayers (SAMs). The much stronger covalent bonds increase TBC twofold. (b) The average transmission coefficient  $\langle \alpha_{\min \to \max} \rangle$  increases monotonically with the strength of interfacial bonding, as represented by the work of adhesion, for a series of four metals on diamond.  $\langle \alpha_{\min \to \max} \rangle$  is defined as the ratio of the measured TBC (47) to the calculated MTL (perfect-transmission) limit. Diamond's work of cohesion  $W_{\text{coh}} = 5.61 \text{ J/m}^2$ . (c) Effect of adding Cr to a Cu matrix in Cu/diamond composites formed by liquid-metal infiltration (16). For Cr concentrations above  $\sim 10^{-3}$ , a Cr carbide layer forms at the surface of the diamond particles. This interlayer dramatically increases the affinity between Cu and diamond, as manifested by three simultaneous property transitions: increased wettability [reduced contact angle; purple data (145)], reduced coefficient of thermal expansion (CTE) (green data) from that of pure copper (17 ppm/K) to a weighted average with diamond (1 ppm/K), and a fivefold increase in  $k_{\text{composite}}$  (blue data). Without the bridging carbide, CTE<sub>composite</sub> and  $k_{\text{composite}}$  behave as if the diamonds were not even present. (d) In a complementary single-interface study, a sub-1-nm layer of Cr was found to enhance the TBC between Cu and

diamond 15-fold (unpublished TDTR measurements from Reference 131), consistent with the increase in  $k_{\text{composite}}$  from panel  $\epsilon$ .

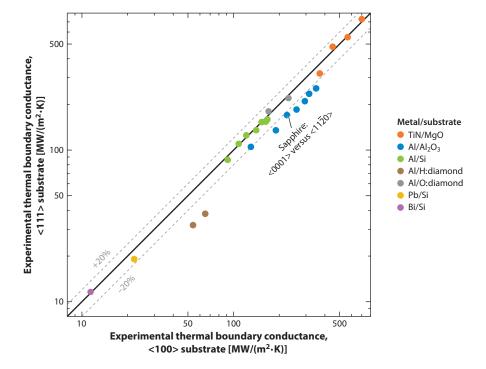


Figure 8

Comparison of thermal boundary conductance (TBC) on <100>-oriented substrates versus <111>-oriented substrates (<0001> versus  $<11\bar{2}0>$  for sapphire) as measured by TDTR around room temperature. Although there is little substrate orientation effect in this data set, for these couples the weak-irradiance side is the metal, so the measured TBC is expected to be relatively insensitive to any irradiance variations from the substrate side. The most prominent deviation from the 1:1 line is for Al on hydrogen-terminated diamond (*brown data*), but this deviation is actually because of known stronger adhesion on <100> faces (i.e., larger  $<\alpha>$ ) for this system. Data from References 2, 33, 127, and 153.

the diamond, but by the [111] face having a higher surface density of hydrogen (which is a weak bond) than the [100] face.

#### 4.6. Interfacial Roughness

Intuitively, TBC could be influenced by roughness whose scale is comparable to or larger than the wavelengths of the thermal phonons (36), which is practically always the case for real interfaces at room temperature. However, the notion of direct roughness effects on TBC should be carefully treated for several reasons.

First, the most common metric, the rms roughness, is a single number. The surface-area enhancement and average slope should also play essential roles, but even the most basic quantification of the roughness spectrum is rarely reported. Second, the choice of roughness measurement tool has a significant influence on the reported roughness (154). Moreover, typical AFM tips have a radius of approximately 10 nm at best, thereby underestimating finer-scale roughness (155). Finally, the processing method (e.g., etching) used to control the interfacial roughness may also change the surface chemistry, and disentangling the direct effects of roughness from the chemistry-induced changes in  $\langle \alpha \rangle$  may not be possible.

Experimental evidence by Hopkins and colleagues (44, 143, 156) suggests that, for an Al/Si interface, increasing interface roughness degrades the TBC. Measurements on the Rh:Fe/Al<sub>2</sub>O<sub>3</sub> system by Swartz & Pohl (26) also suggest a decrease in conductance with increasing interfacial roughness. MD calculations have supported both possibilities (68, 157). Measurements by Edtmaier et al. (158) found that a roughening treatment applied to diamond particles improved  $k_{\text{composite}}$  of an MMC made by liquid Al infiltration. However, the roughening treatment involved strong acids, which terminate the diamond surface with oxygen (159) and may thus improve TBC due to this effect (recall **Figure 5**) rather than the roughness (34, 108).

A related geometric consideration that could potentially influence TBC is curvature of the interface, for example, in the case of grain boundaries. Grain boundary curvature with high spatial frequencies can be considered as in the roughness discussion just presented. More gradual grain boundary curvature could conceivably impact the TBC through the angular dependence of *H* due to phonon focusing effects, even in a cubic material, as discussed in Section 4.5. However, neither of these potential grain boundary curvature effects on TBC has been clearly documented in the experimental literature.

#### 4.7. Hydrostatic Pressure

Hsieh et al. (42) and Hohensee et al. (130) showed that applying a hydrostatic (isotropic) pressure from 0 to  $\sim$ 10 GPa on clean Al/SiC and M/diamond (M = Pt, Au, Pb, Al) interfaces moderately increases the measured TBC (by tens of percent up to a factor of two), due to changes in the dispersion relations and thus H. Pressure effects on TBC are much more dramatic, up to eightfold, for purposely weakened interfaces (native SiO<sub>2</sub> on SiC, or incorporating a graphene sheet at the interface). At even higher pressures [up to 50 GPa (130)], weak interfaces undergo a permanent change thought to improve the interfacial bonding and thus  $\alpha$ . The resulting TBCs are as high as or higher than any other experimental reports for the same couple (see the DAC points in **Figure 5**).

#### 4.8. Other Effects

Confinement and dislocation density effects have also been briefly investigated. Krenzer et al. (160) used ultrathin Bi layers to explore possible effects of phononic confinement on TBC through  $\langle \alpha \rangle$ . Despite film thicknesses down to 2.5 nm, the measured TBC remained constant. Calculations suggest that measurable phonon quantization effects would require film thicknesses close to a monolayer (at  $T \sim 100$  K and up), which is an experimental challenge and calls into question any model based on bond stiffnesses from bulk Bi.

The effects of dislocation density have also been investigated in the context of in-plane dislocation spacings as small as  $\sim$ 20 nm. Measurements of two GaSb epitaxial films (161) revealed a reduction in TBC in the film with increased dislocation density, although the same film also had a higher surface roughness, complicating the interpretation. A related dislocation density study of the Bi/Si system (91) found no effect.

#### 5. CONCLUSION AND OUTLOOK

#### 5.1. Key Physical Insights

The guiding perspective of this review is that TBC is determined by two key phenomena (**Figure 1**): (a) the irradiance of heat carriers bombarding an interface,  $H_i$ , and (b) their corresponding transmission probabilities,  $\langle \alpha_{ij} \rangle$ . The irradiance depends on each material's heat capacity and carrier velocity through Equation 1 or Equation 7. The two materials are often highly

mismatched, in which case TBC is limited by the material with the weaker  $\frac{\partial H}{\partial T}$  (e.g., **Figure 6**). The average transmission probabilities  $\langle \alpha \rangle$  are complex and remain hard to predict, calling into question the suitability of the classic AMM and DMM. The experiments collected above show that surface preparation and chemistry routinely impact  $\langle \alpha \rangle$  by factors of 2 to 5—and, in some cases, by a factor of more than 100—for a given materials pair (**Figures 5** and **7**). Nevertheless, the simple limit of  $\alpha_{\min \to \max} = 1$ , that is, the MTL (Equation 11), proves to be a useful upper bound, and most of the high-quality interfaces surveyed above exhibit TBCs within a factor of  $\frac{1}{5}$  or even  $\frac{1}{2}$  of the MTL.

#### 5.2. Major Advances over the Last 25 Years

The major theoretical advances have been computational. Molecular and lattice dynamics methods have been refined and complemented by Green's function and wave packet methods. Atomistic Green's functions using DFT-derived potentials for both bulk and interfacial atoms are promising, although realistic quantitative calculations have yet to be made. Additionally, a growing body of experimental evidence is steering the theoretical understanding from an acoustic or diffuse mismatch picture back to a broader view based on heat carrier irradiance. The perfect-transmission approximation (the MTL) consistently overestimates measurements on high-quality systems by a factor of 2 to 5 but seems to better explain general trends in temperature or when different materials are compared.

On the experimental side, thermally modulated techniques, particularly the workhorse TDTR, have enabled a wealth of measurements. The greatest fundamental challenge now is preparing chemically clean, well-understood interfaces. TBC experimentalists have explored various materials science parameters such as substrate orientation and dispersion relation, interfacial layers and roughness, and hydrostatic pressure. Their collected results provide invaluable experimental grounding for thermal design at the nanoscale, with broad technological relevance from microelectronics to LEDs.

#### 5.3. Needs and Opportunities

The TBC community appears close to realizing good agreement between experiments and computations without any free parameters. Achieving such predictive power across a range of systems would be a major milestone but requires further advances in both areas, especially at the interface:

- Computational: Moving beyond theoretically perfect systems is probably the greatest challenge. The interatomic potentials must be highly accurate to capture realistic bonding, defects, and anharmonicities throughout the interfacial region and to provide the deepest understanding of TBC. A theoretical framework to rigorously treat interfaces using first-principles approaches (beyond the one provided by atomistic Green's functions) has yet to be developed.
- Experimental: Identifying and producing clean, epitaxial systems in materials pairs with highly mismatched irradiances would give excellent grounds for comparison with computational results. More thorough, nonthermal characterization of interfaces as a complement to existing measurement techniques is needed to better understand TBC fundamentals at the nanoscale. Extremely fine scale structural characterization is needed because, at ambient temperature and above, the dominant phonon wavelengths are of the order of one interatomic distance, so the interface should be well characterized at that same scale.

Among materials classes, amorphous materials and metal/metal interfaces will benefit from deeper investigations. Interfaces involving amorphous materials have not been carefully addressed

by modeling or experiment, in spite of their growing significance in state-of-the-art microelectronics. Modeling their TBC may involve some subtleties because the vibrational energy transfer in amorphous materials is extremely short range (162, 163), challenging even the basic Landauer-Büttiker picture. Regarding electron-dominated interfaces, only two systems have been investigated in depth (**Figure 6***b*), although neither was highly mismatched. Thus, more measurements using metal pairs with widely contrasting Fermi velocities and Sommerfeld parameters will enable a more compelling assessment of current theories.

From an applications perspective, work is needed to understand the impact of each fabrication step on the TBC of any given interface. We show above that TBC can be extremely sensitive to interfacial treatments using well-controlled chemistry in the lab (e.g., **Figures 5** and 7), but much less work has been done for industrially relevant interfacial processing steps. For example, does stripping photoresist impact the TBC between two successive layers in a stack; would a plasma cleaning step improve it; and if so, why? Such research is challenging because it requires making interfaces "dirty" in a reproducible way, but the resulting understanding could enable major thermal management improvements at only modest cost.

#### DISCLOSURE STATEMENT

The authors are not aware of any affiliations, memberships, funding, or financial holdings that might be perceived as affecting the objectivity of this review.

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